

## Supporting Information

# Design of Cobalt Phosphate/Nickel phosphate Film with Improved Electrochromic Performance

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### Supplementary Table

Table S1. EC properties of the NiO films with porous nanostructures.

materials	optical modulation	coloration efficiency (cm <sup>2</sup> C <sup>-1</sup> )	switching time tc/tb	cycle stability	reference
NiO	78.5% at 550nm	51.8	3.92s / 3.43s	1000	[1]
NiO	51% at 550nm	40	7s / 5s	3000	[2]
NiCoO <sub>2</sub>	64.2% at 550nm	33.6	6.8 / 6.7s	200	[3]
NiHCF	17.5% at 400nm	/	21.5min / 8.5s	55	[4]
Li-Ti-NiO	56% at 580nm	21.8	0.9s / 1.0s	300	[5]
Sn-NiO	65.1% at 550nm	39.3	1.3s / 1.4s	500	[6]
rGO-NiO	53% at 630nm	30.5	3.4s / 5.3s	1000	[7]
OL-NiO	54.27% at 450nm	48.5	3.2s / 2.7s	/	[8]
NiHPO <sub>4</sub>	90.8% at 500nm	75.4	7.1/9.6	300	[9]
CoHPO <sub>4</sub> /NiHPO <sub>4</sub>	65.55% at 500nm	140.37	2.0/8.5	1400	This work

Table S2. Anode and cathode peak current density vs (scan rate)<sup>1/2</sup> plot obtained from CV curves, corresponding linear fits of the CoHP/NiHP-1 film, CoHP/NiHP-2 film, CoHP/NiHP-3 film, CoHP/NiHP-4 film, CoHP/NiHP-5 film CoHP/NiHP-6 film.

	CoHP/NiHP-1 film	CoHP/NiHP-2 film	CoHP/NiHP-3 film	CoHP/NiHP-4 film	CoHP/NiHP-5 film	CoHP/NiHP-6 film
<b>Oxidative linear fits</b>	$I = -0.456 + 0.77 \times v^{1/2}$ R <sup>2</sup> =0.99952	$I = -1.1818 + 1.28 \times v^{1/2}$ R <sup>2</sup> =0.99985	$I = -1.15 + 1.49 \times v^{1/2}$ R <sup>2</sup> =0.99913	$I = -0.48 + 1.64 \times v^{1/2}$ R <sup>2</sup> =0.99981	$I = 0.252 + 1.59 \times v^{1/2}$ R <sup>2</sup> =0.99942	$I = 0.756 + 1.52 \times v^{1/2}$ R <sup>2</sup> =0.99945
<b>Reductive linear fits</b>	$I = 0.392 - 0.66 \times v^{1/2}$ R <sup>2</sup> =0.99976	$I = -0.925 - 1.04 \times v^{1/2}$ R <sup>2</sup> =0.99967	$I = 1.03 - 1.23 \times v^{1/2}$ R <sup>2</sup> =0.99917	$I = 0.45 - 1.28 \times v^{1/2}$ R <sup>2</sup> =0.99972	$I = -0.018 - 1.23 \times v^{1/2}$ R <sup>2</sup> =0.99911	$I = -0.796 - 1.19 \times v^{1/2}$ R <sup>2</sup> =0.99942

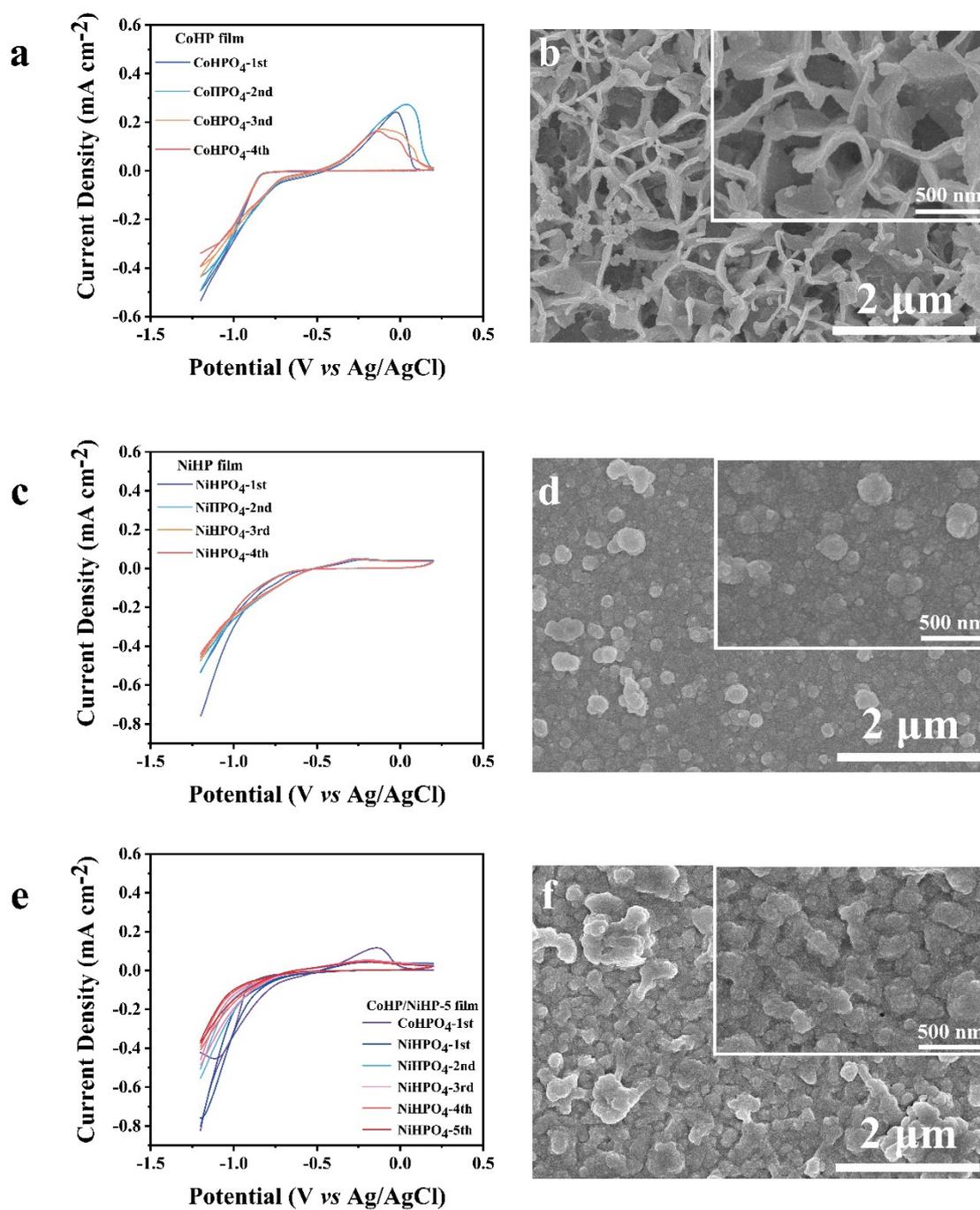
Table S3. Anode and cathode peak current density vs (scan rate)<sup>1/2</sup> plot obtained from CV curves, corresponding linear fits and diffusion coefficient of the CoHP film, NiHP film and CoHPO<sub>4</sub>/NiHPO<sub>4</sub> film (CoHP/NiHP-4 film).

	CoHP film	NiHP film	CoHP/NiHP-4 film
<b>Oxidative linear fits</b>	$I = -2.31 + 1.37 \times v^{1/2}$ R <sup>2</sup> =0.99904	$I = -1.05 + 1.49 \times v^{1/2}$ R <sup>2</sup> =0.99979	$I = -0.48 + 1.64 \times v^{1/2}$ R <sup>2</sup> =0.99981
<b>Reductive linear fits</b>	$I = 1.85 - 1.25 \times v^{1/2}$ R <sup>2</sup> =0.99937	$I = -0.51 - 1.08 \times v^{1/2}$ R <sup>2</sup> =0.99935	$I = 0.45 - 1.28 \times v^{1/2}$ R <sup>2</sup> =0.99972

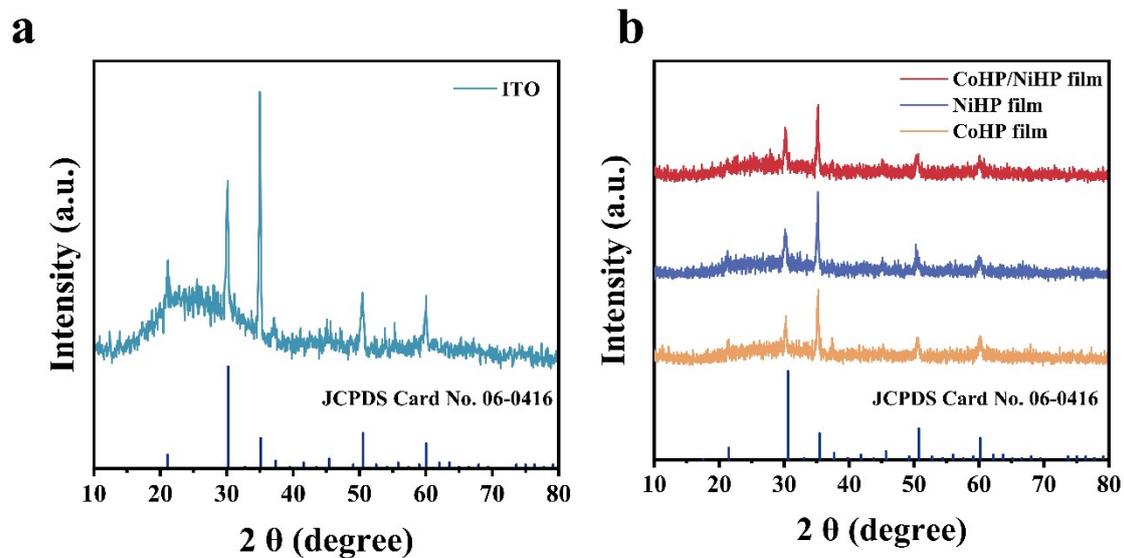
**Table S4.** The transmittance of initial state, bleached state and color state of the CoHP/NiHP-1 film, CoHP/NiHP-2 film, CoHP/NiHP-3 film, CoHP/NiHP-4 film, CoHP/NiHP-5 film CoHP/NiHP-6 film.

	CoHP/NiHP-1 film	CoHP/NiHP-2 film	CoHP/NiHP-3 film	CoHP/NiHP-4 film	CoHP/NiHP-5 film	CoHP/NiHP-6 film
<b>T<sub>initial</sub></b>	94.86%	93.90%	91.45%	89.53%	88.72%	88.13%
<b>T<sub>bleached</sub></b>	88.25%	87.62%	87.33%	87.03%	85.94%	85.39%
<b>T<sub>colored</sub></b>	63.25%	42.57%	28.99%	21.48%	20.09%	19.15%
<b>ΔT</b>	25.00%	45.05%	58.34%	65.55%	65.85%	66.24%

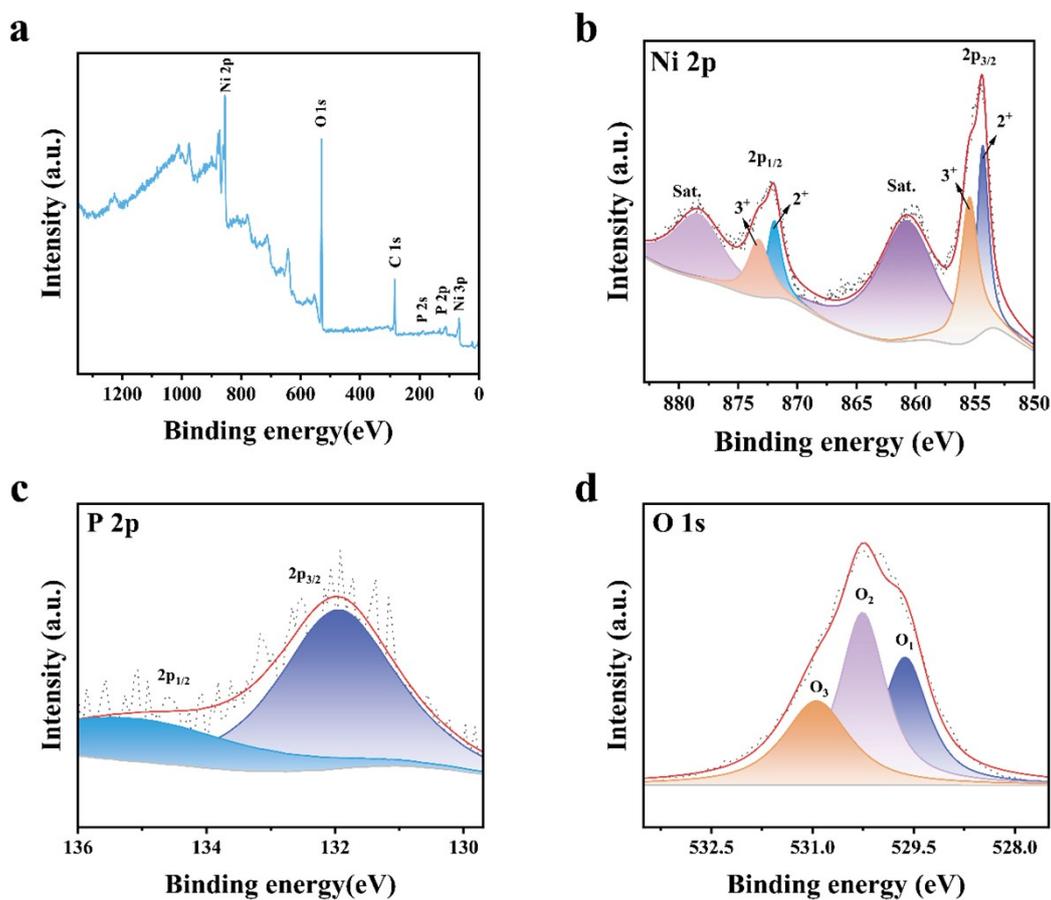
## Supplementary Figures



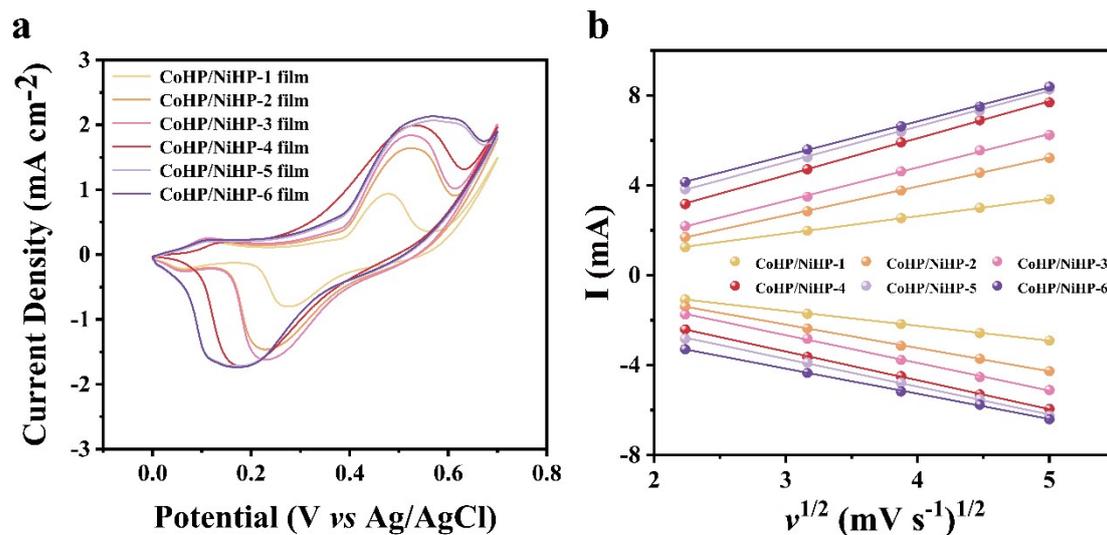
**Fig. S1** The two-step electrochemical deposition CV curves while prepared (between -1.2 and 0.2 V vs. Ag/AgCl,  $20 \text{ mV s}^{-1}$ ) and corresponding top-view SEM images of (a-b) CoHP film, (c-d) NiHP film and (e-f) CoHP/NiHP-5 film.



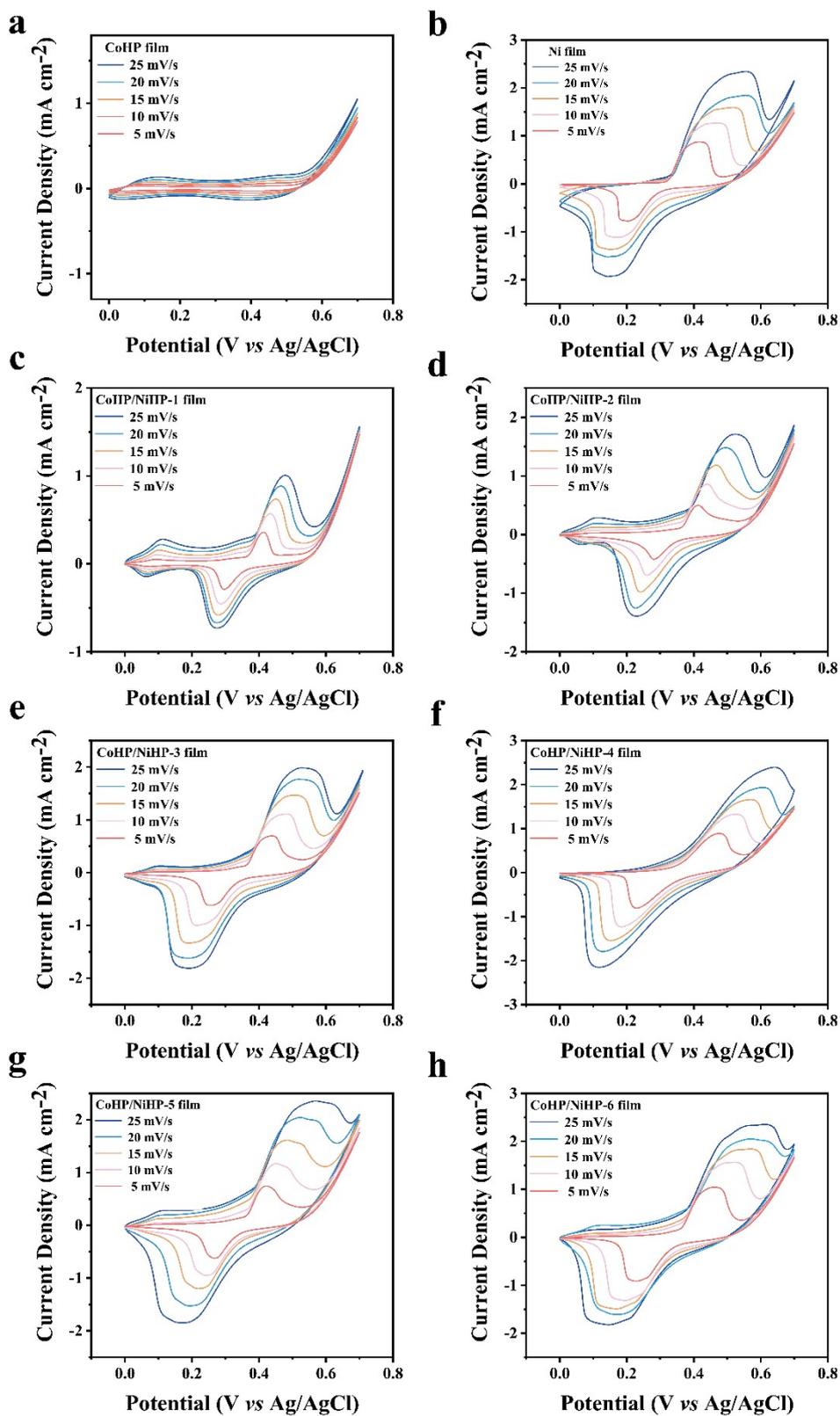
**Fig. S2** XRD patterns of (a) purchased clean ITO glass and (b) CoHP film, NiHP film and CoHP/NiHP film.



**Fig. S3** (a) XPS spectrum of the NiHP film, (b-d) Ni 2p, O 1s and P 2p spectrum of the NiHP film.



**Fig. S4** (a) CV curve comparison between CoHP/NiHP-1 film, CoHP/NiHP-2 film, CoHP/NiHP-3 film, CoHP/NiHP-4 film, CoHP/NiHP-5 film CoHP/NiHP-6 film at the scan rate of 20 mV s<sup>-1</sup>, (b) Anode and cathode peak current density vs (scan rate)<sup>1/2</sup> plot obtained from CV curves and corresponding linear fits of the CoHP/NiHP-1 film, CoHP/NiHP-2 film, CoHP/NiHP-3 film, CoHP/NiHP-4 film, CoHP/NiHP-5 film CoHP/NiHP-6 film.



**Fig. S5** CV curves of (a) CoHP film, (b) NiHP film (c) CoHP/NiHP-1 film,(d) CoHP/NiHP-2 film,(e) CoHP/NiHP-3 film,(f) CoHP/NiHP-4 film, (g)CoHP/NiHP-5 film and (h) CoHP/NiHP-6 film at various scan rates from  $5 \text{ mV s}^{-1}$  to  $25 \text{ mV s}^{-1}$ .

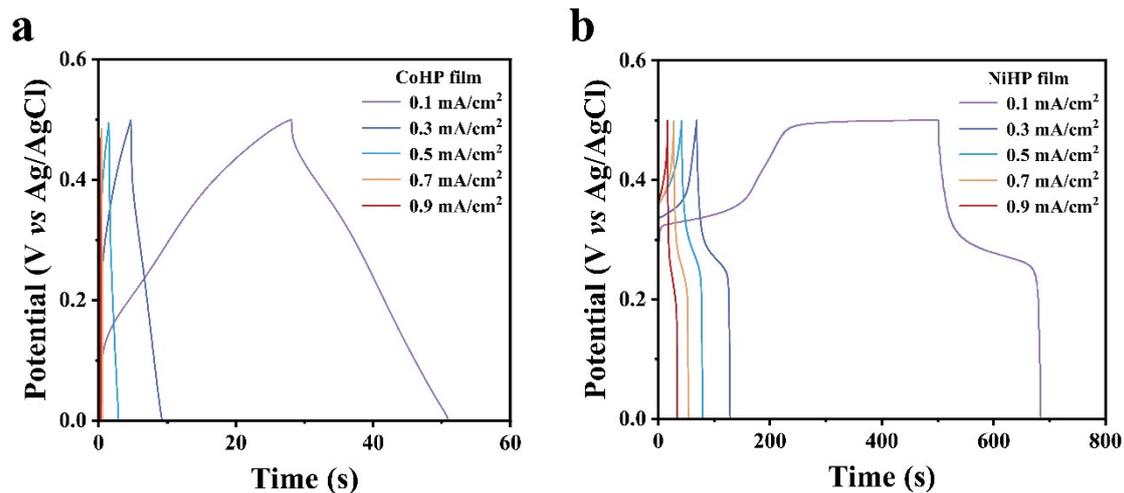


Fig. S6 GCD curves of (a) CoHP film and (b) NiHP film in 0.1 M KOH under multiple discharging current densities.

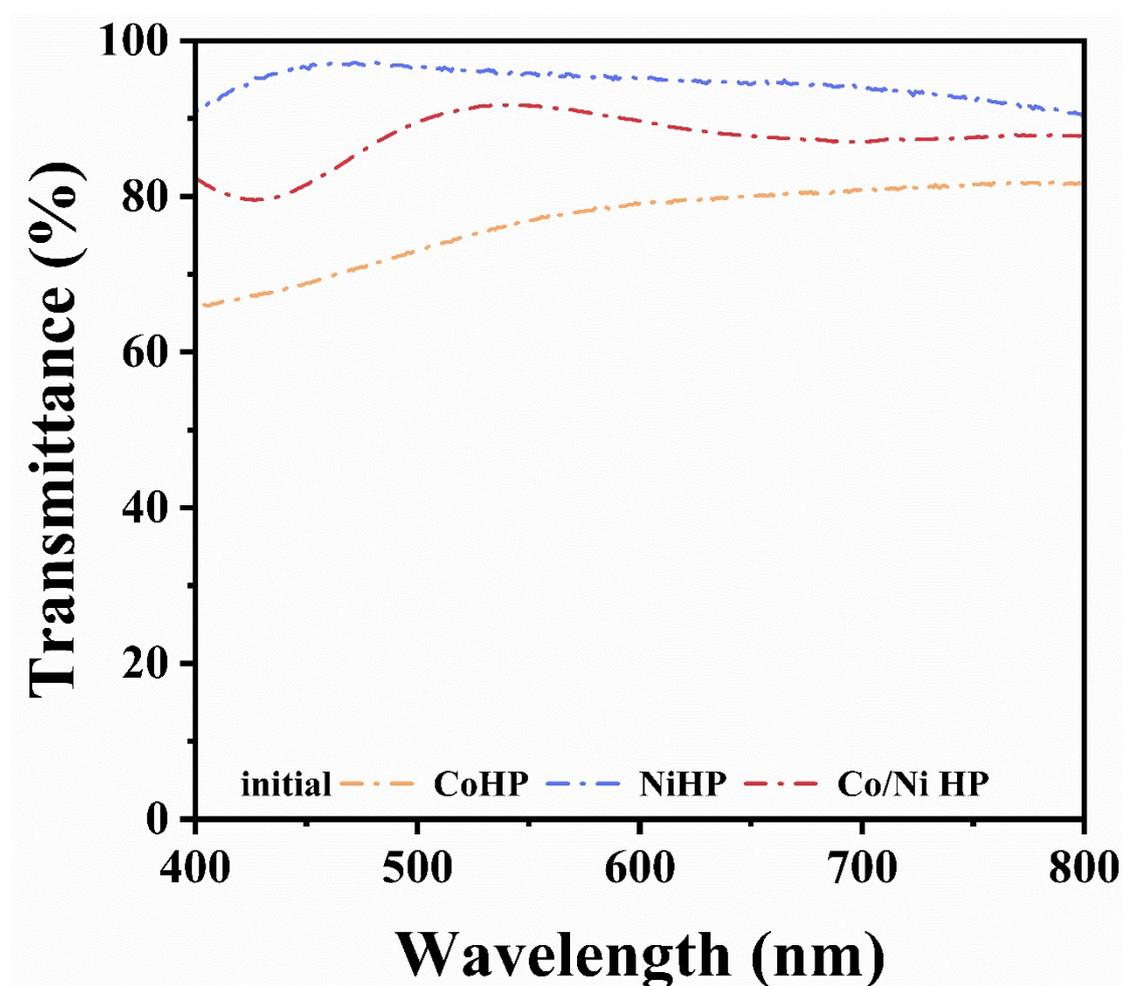


Fig. S7 Initial state of CoHP film, NiHP film and CoHP/NiHP film.

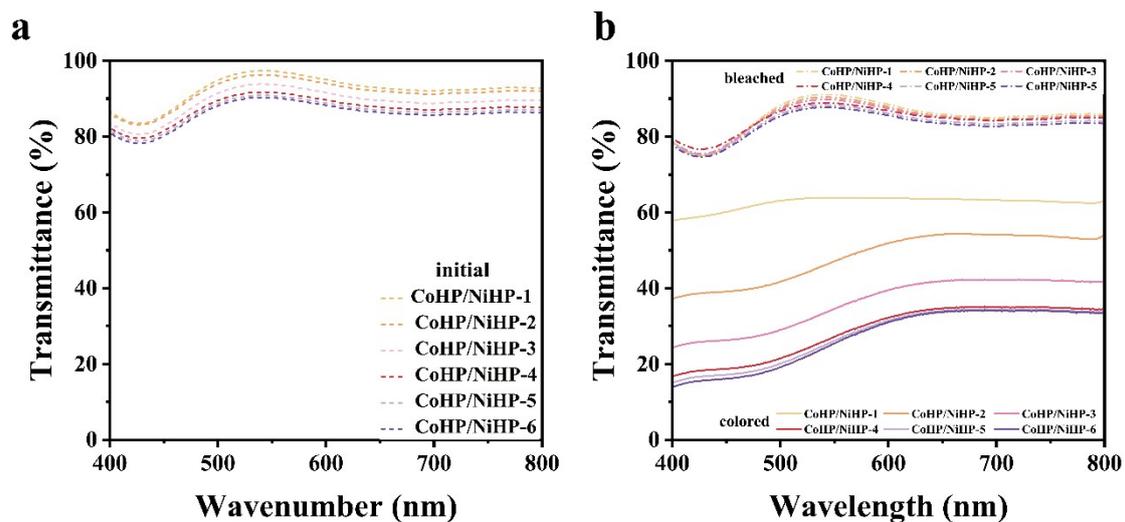


Fig. S8 (a)The initial state transmittance and (b) the bleached state and the colored state of CoHP/NiHP film with different numbers of electrodeposited CV cycles.

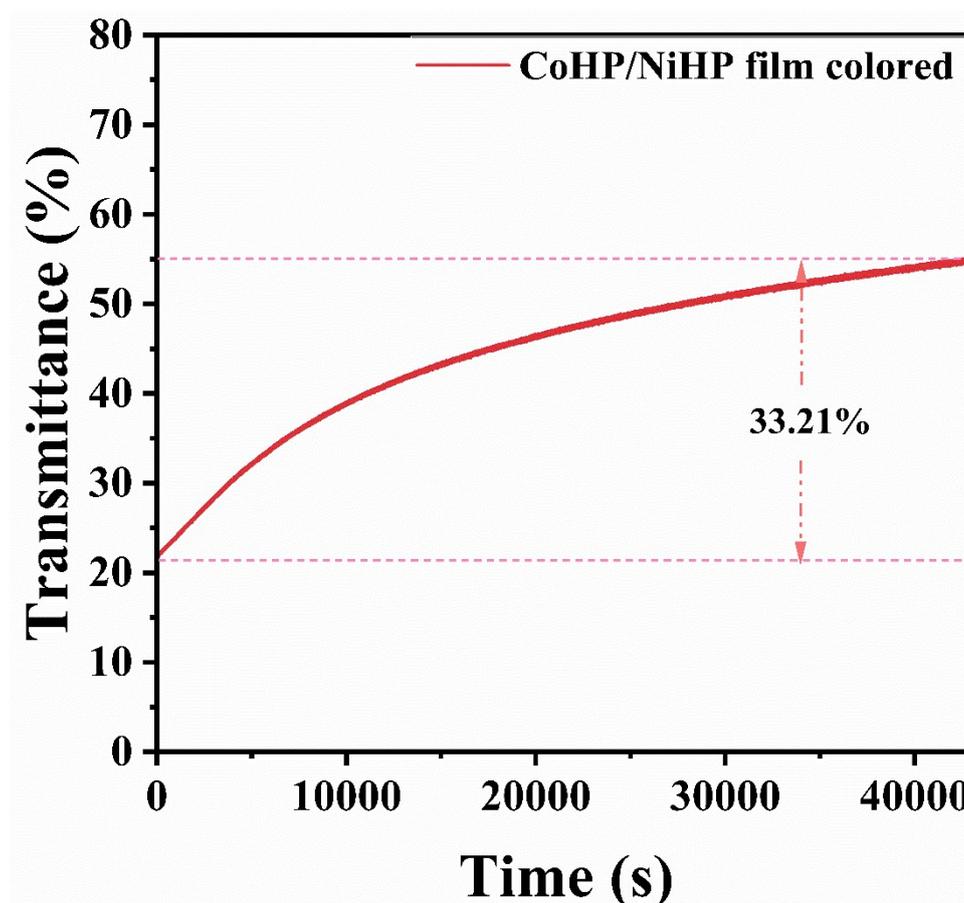
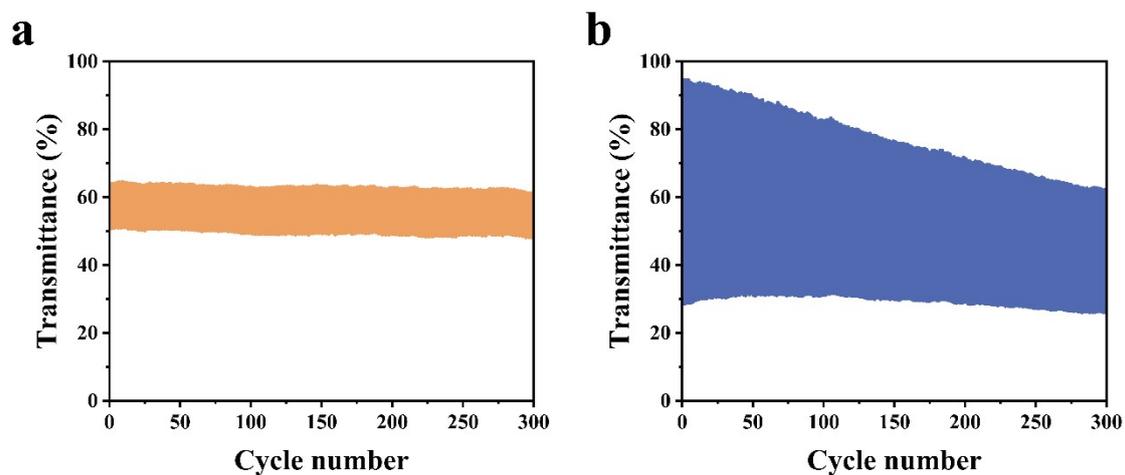
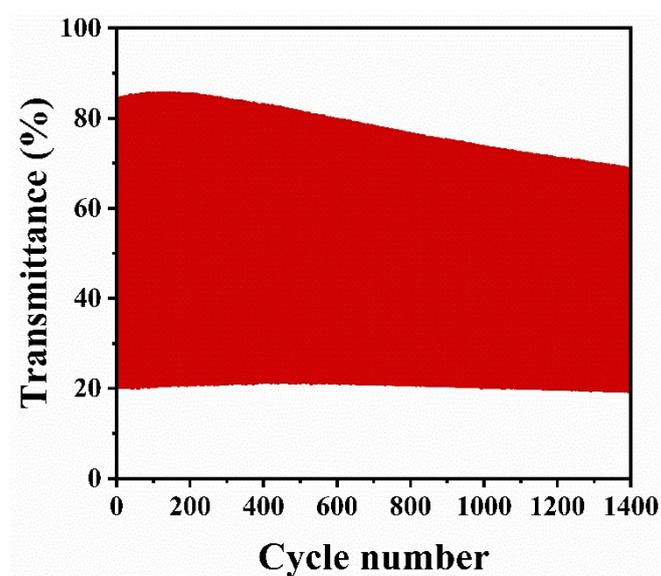


Fig. S9 Optical memory at 500 nm of the CoHP/NiHP film at stimulation voltages of 0.7 V (vs. Ag/AgCl) for 60 s, power off for 43200 s.



**Fig. S10** 300 cycles cyclic stability measurement of (a) CoHP film and (b) NiHP film at 500 nm by chronoamperometry and in-situ spectroscopic response.



**Fig. S11** 1400 cycles cyclic stability measurement of CoHP/NiHP film at 500 nm by chronoamperometry and in-situ spectroscopic response.

#### Reference:

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